

**Search Notes**

Application/Control No.

10/721,334

Examiner

HIEU T. VO

Applicant(s)/Patent under  
Reexamination

KOBAYASHI ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
701	114 115 101 102 29 35	6/23/2005	VH
73	116 117.3	6/23/2005	VH
Updated	search	10/30/2005	VH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
All of above		10/30/2005	VH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/27/2005	VH